

H-field and B-field

3/7/2017

The magnetic field can be defined in several equivalent ways based on the effects it has on its environment.

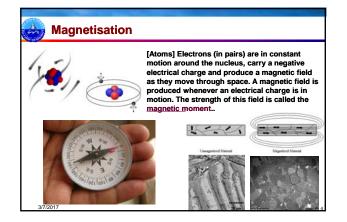
B-field: the magnetic field is defined by the force it exerts on a moving charged particle.

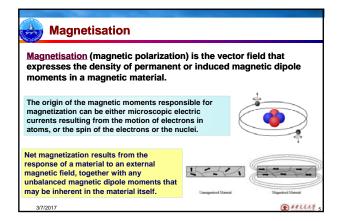
$$\mathbf{F} = q(\mathbf{E} + \mathbf{v} \times \mathbf{B})$$

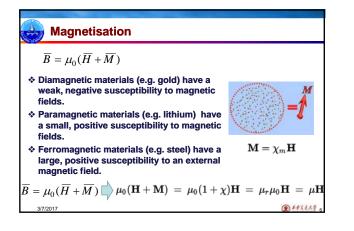
H-field: there is a quantity *H*, which is also sometimes called the magnetic field. In a vacuum, *B* and *H* are proportional to each other, with the multiplicative constant depending on the physical units. Inside a material they are different (<u>*H*</u> and $B \rightarrow$ inside and outside of magnetic materials).

$$\overline{B} = \mu_0 (\overline{H} + \overline{M})$$

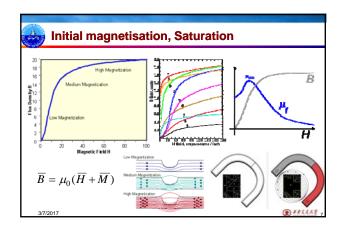
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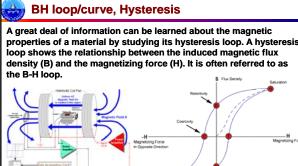




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properties of a material by studying its hysteresis loop. A hysteresis loop shows the relationship between the induced magnetic flux



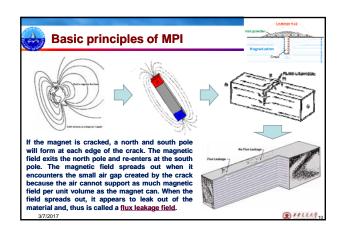


Magnetic Particle Inspection (MPI) Ô

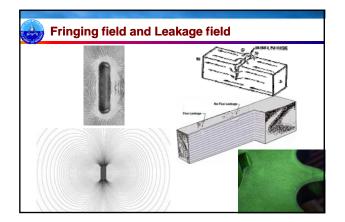
"This method is used for the detection of surface and near-surface flaws in "erromagnetic materials and is primarily used for crack detection. The specimen is magnetised either locally or overall, and if the material is sound the magnetic flux is predominantly inside the material. If, however, there is a surface-breaking flaw, the magnetic field is distorted, causing local magnetic flux leakage around the flaw. This leakage flux is displayed by covering the surface with very fine iron particles applied either dry or suspended in a liquid. The particles accumulate at the regions of flux leakage, producing a build-up which can be seen visually even when the crack opening is very narrow. Thus, a crack is indicated as a line of iron powder particles on the surface."











Magnetic Flux Leakage (MFL)

"As with MPI, the ferromagnetic specimen is magnetised, and depending upon the level of induced flux density, magnetic flux leakage due to both near- and farsurface flaws is detected by a <u>Hall effect element</u>, which is traversed over the surface of the specimen.

Unlike MPI, the method is not limited to surface-breaking or near-surface flaws, but actually becomes increasingly sensitive to <u>far-surface flaws</u> with increasing levels of magnetisation. "



